



N-Channel Enhancement Mode Power MOSFET

MTN10N60CFP

| | |
|---|-------|
| BV _{DSS} | 600V |
| I _D @ V _{GS} =10V, T _C =25°C | 10A |
| R _{DS(on)(TYP)} @ V _{GS} =10V, I _D =6A | 0.54Ω |

Description

The MTN10N60CFP is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220FP package is universally preferred for all commercial-industrial applications

Features

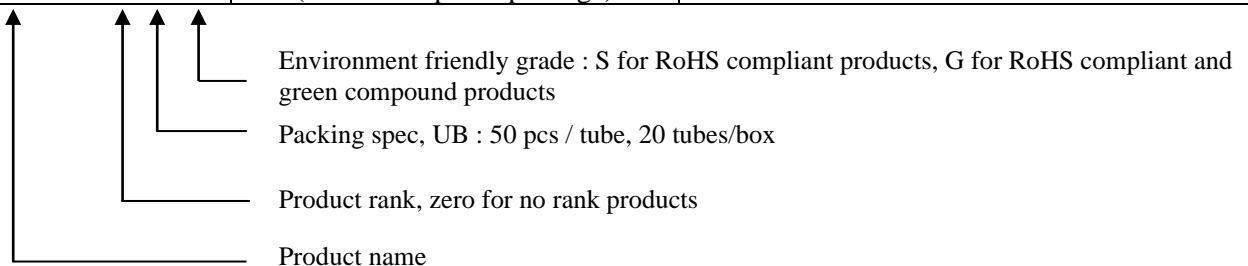
- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- Insulating package, front/back side insulating voltage=2500V(AC)
- RoHS compliant package

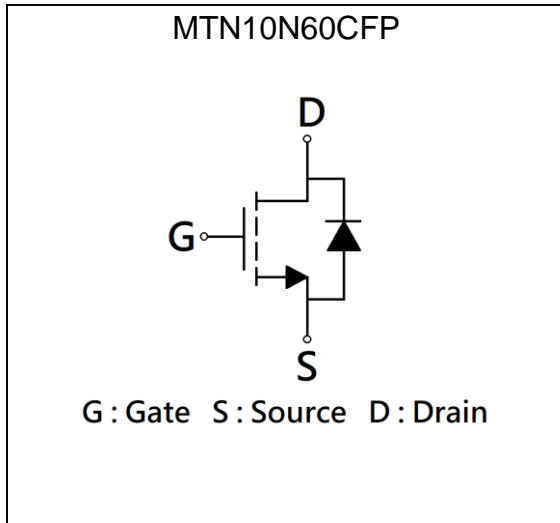
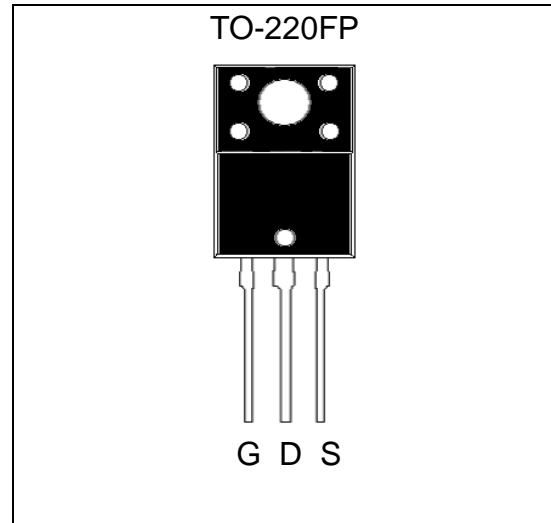
Applications

- Power Factor Correction
- LCD TV Power
- Full and Half Bridge Power

Ordering Information

| Device | Package | Shipping |
|--------------------|--------------------------------------|---|
| MTN10N60CFP-0-UB-S | TO-220FP (RoHS compliant package) | 50 pcs/tube, 20 tubes/box, 5 boxes / carton |



Symbol

Outline

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$)

| Parameter | Symbol | Limits | Unit |
|--|----------------|----------|---------------------|
| Drain-Source Voltage (Note 1) | V_{DS} | 600 | V |
| Gate-Source Voltage | V_{GS} | ± 30 | |
| Continuous Drain Current @ $V_{GS}=10\text{V}$, $T_C=25^\circ\text{C}$ | I_D | 10* | A |
| Continuous Drain Current @ $V_{GS}=10\text{V}$, $T_C=100^\circ\text{C}$ | | 6.3* | |
| Pulsed Drain Current @ $V_{GS}=10\text{V}$ (Note 2) | | 40* | |
| Single Pulse Avalanche Current @ $L=0.1\text{mH}$ | I_{AS} | 10 | |
| Single Pulse Avalanche Energy @ $L=5\text{mH}$, $I_D=9\text{Amps}$, $V_{DD}=50\text{V}$ (Note 3) | E_{AS} | 202.5 | mJ |
| Repetitive Avalanche Energy (Note 2) | E_{AR} | 5 | |
| Maximum Temperature for Soldering @ Lead at 0.063 in(1.6mm) from case for 10 seconds | T_L | 300 | $^\circ\text{C}$ |
| Maximum Temperature for Soldering @ Package Body for 10 seconds | T_{PKG} | 260 | |
| Total Power Dissipation ($T_C=25^\circ\text{C}$) | P_d | 54 | W |
| Linear Derating Factor | | 0.4 | W/ $^\circ\text{C}$ |
| Operating Junction and Storage Temperature | T_j, T_{stg} | -55~+150 | $^\circ\text{C}$ |

*Drain current limited by maximum junction temperature

Note : 1. $T_J=+25^\circ\text{C}$ to $+150^\circ\text{C}$.

2. Pulse width limited by maximum junction temperature.

3. 100% tested by conditions of $L=5\text{mH}$, $I_{AS}=5\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=50\text{V}$.



Thermal Data

| Parameter | Symbol | Value | Unit |
|--|------------------|-------|------|
| Thermal Resistance, Junction-to-case, max | R _{θJC} | 2.3 | °C/W |
| Thermal Resistance, Junction-to-ambient, max | R _{θJA} | 62.5 | |

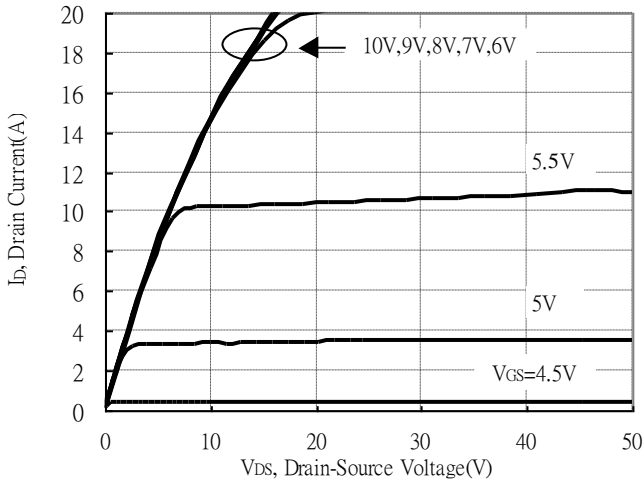
Characteristics (T_j=25°C, unless otherwise specified)

| Symbol | Min. | Typ. | Max. | Unit | Test Conditions |
|-------------------------------------|------|------|------|------|--|
| Static | | | | | |
| BV _{DSS} | 600 | - | - | V | V _{GS} =0V, I _D =250μA |
| ΔBV _{DSS} /ΔT _j | - | 0.7 | - | V/°C | Reference to 25°C, I _D =250μA |
| V _{GS(th)} | 2.0 | - | 4.0 | V | V _{DS} = V _{GS} , I _D =250μA |
| *G _{FS} | - | 12 | - | S | V _{DS} =15V, I _D =5A |
| I _{GSS} | - | - | ±100 | nA | V _{GS} =±30V |
| I _{DSS} | - | - | 1 | μA | V _{DS} =600V, V _{GS} =0V |
| I _{DSS} | - | - | 10 | | V _{DS} =480V, V _{GS} =0V, T _j =125°C |
| *R _{DS(ON)} | - | 0.54 | 0.7 | Ω | V _{GS} =10V, I _D =6A |
| Dynamic | | | | | |
| *Q _g | - | 36.3 | - | nC | I _D =10A, V _{DD} =300V, V _{GS} =10V |
| *Q _{gs} | - | 8.7 | - | | |
| *Q _{gd} | - | 10.7 | - | | |
| *t _{d(ON)} | - | 18.6 | - | ns | V _{DD} =300V, I _D =10A, V _{GS} =10V, R _G =9.1 Ω |
| *t _r | - | 9.2 | - | | |
| *t _{d(OFF)} | - | 63 | - | | |
| *t _f | - | 11.2 | - | | |
| C _{iss} | - | 1651 | - | pF | V _{GS} =0V, V _{DS} =25V, f=1MHz |
| C _{oss} | - | 149 | - | | |
| C _{rss} | - | 26 | - | | |
| Source-Drain Diode | | | | | |
| *V _{SD} | - | 0.84 | 1.2 | V | I _S =10A, V _{GS} =0V |
| *I _S | - | - | 10 | A | |
| *I _{SM} | - | - | 40 | | |
| *t _{rr} | - | 422 | 633 | ns | V _{GS} =0V, I _F =10A, dI _F /dt=100A/μs |
| *Q _{rr} | - | 3.8 | 5.7 | μC | |

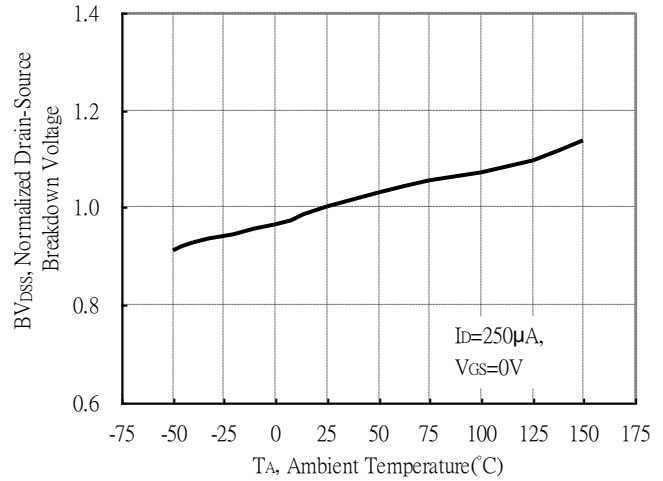
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Typical Characteristics

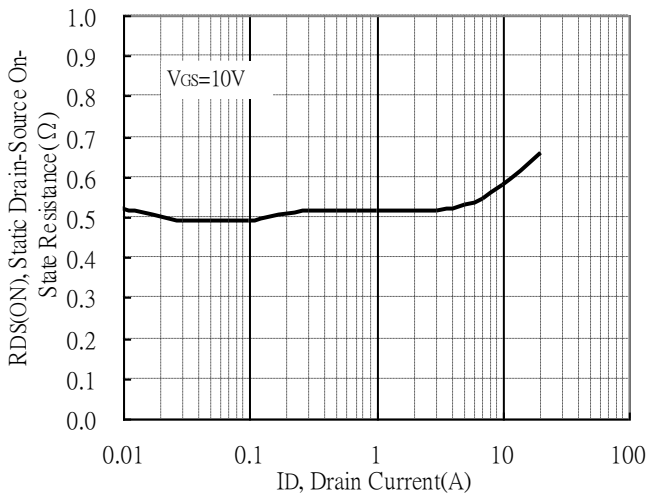
Typical Output Characteristics



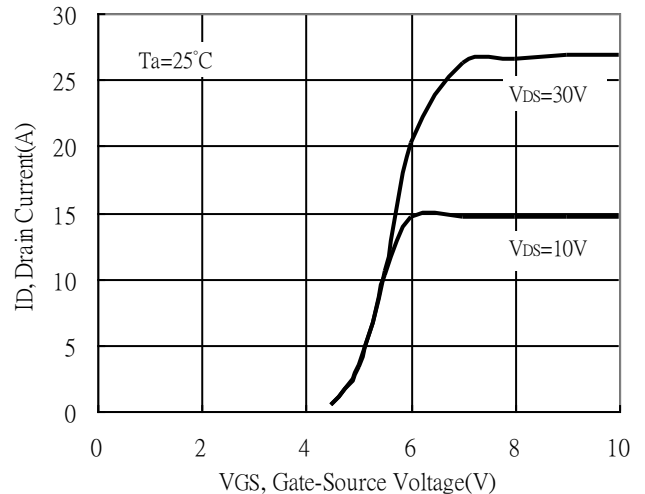
Brekdown Voltage vs Ambient Temperature



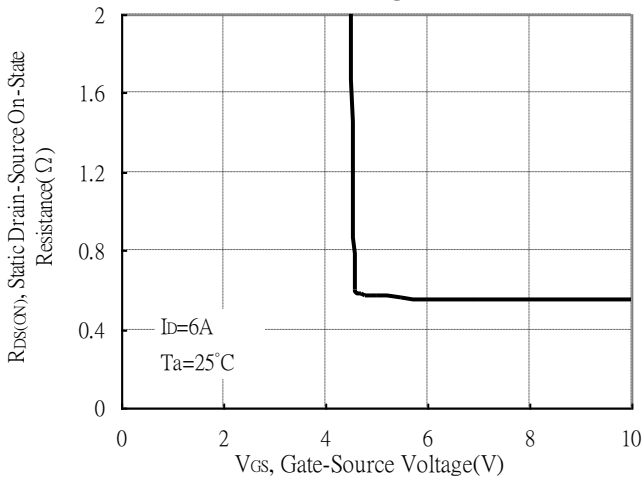
Static Drain-Source On-State resistance vs Drain Current



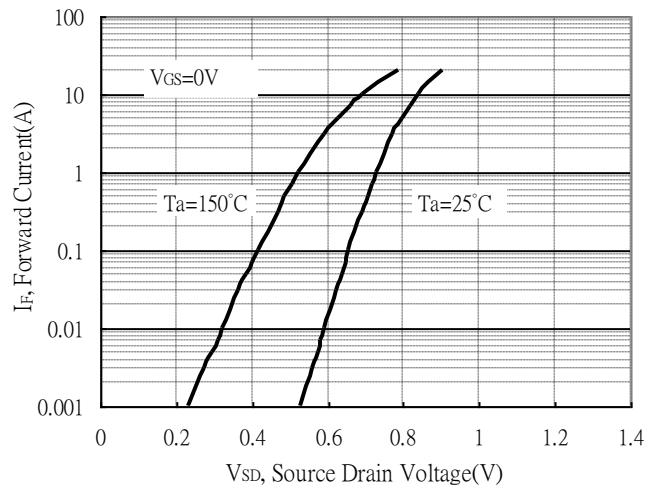
Drain Current vs Gate-Source Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

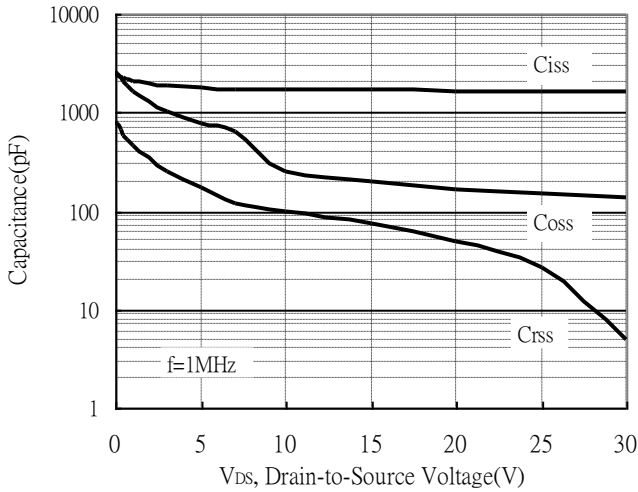


Forward Drain Current vs Source-Drain Voltage

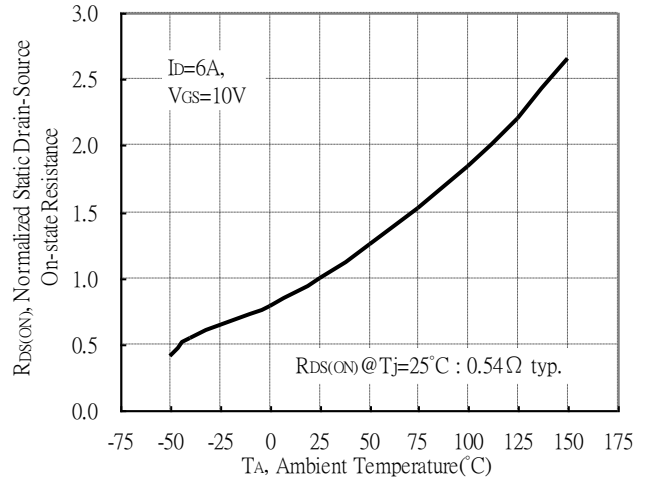


Typical Characteristics(Cont.)

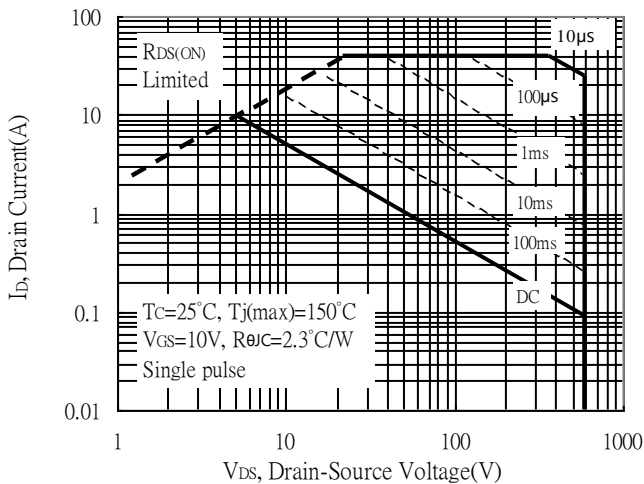
Capacitance vs Reverse Voltage



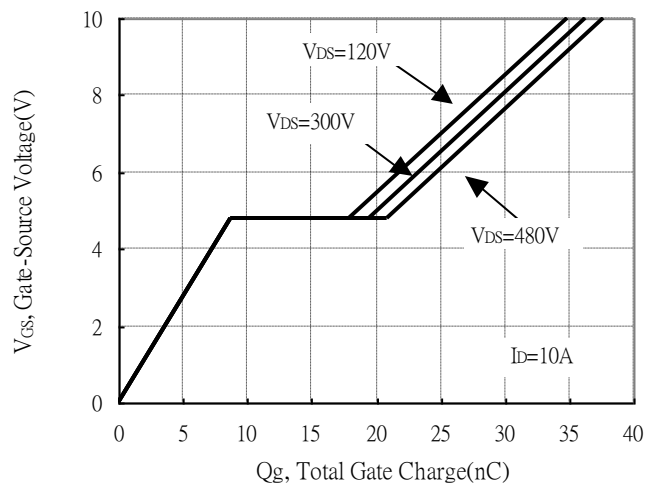
Static Drain-Source On-resistance vs Ambient Temperature



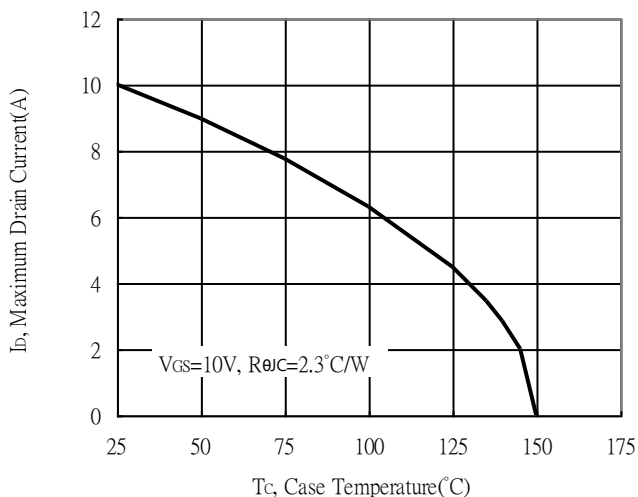
Maximum Safe Operating Area



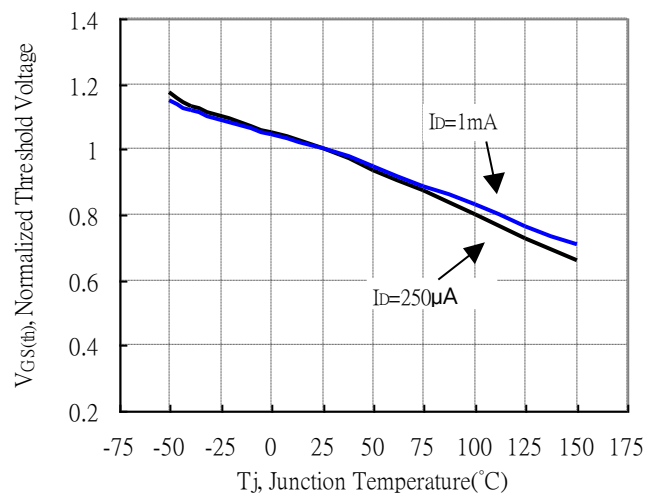
Gate Charge Characteristics



Maximum Drain Current vs Case Temperature

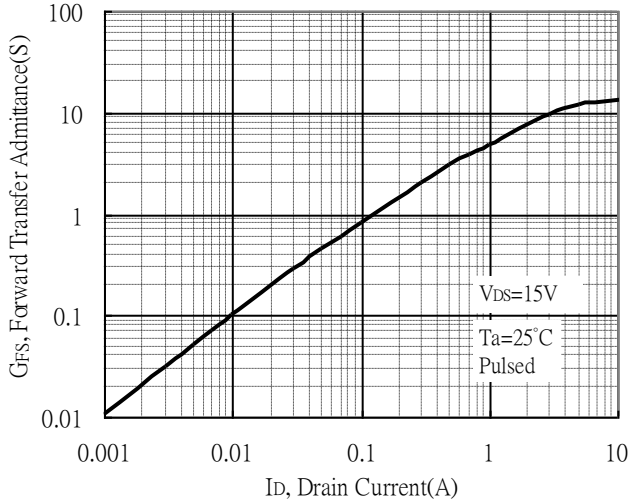


Threshold Voltage vs Junction Temperature

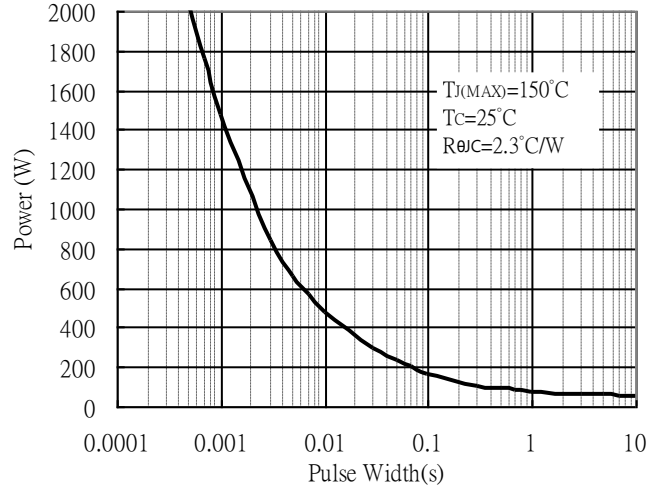


Typical Characteristics(Cont.)

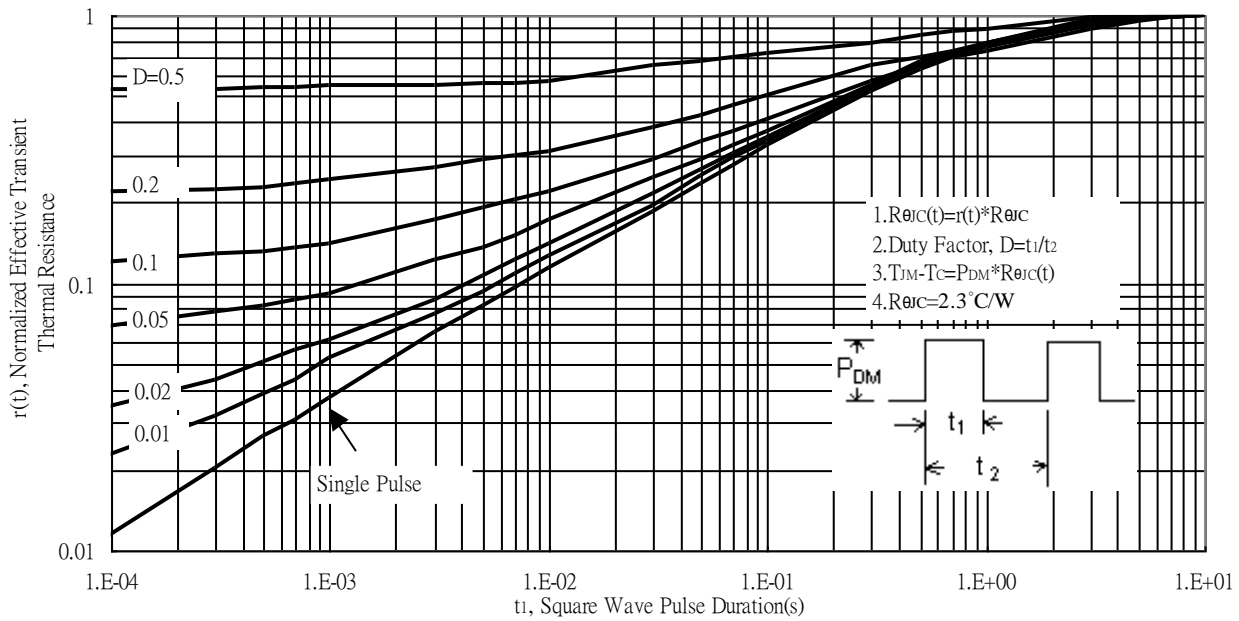
Forward Transfer Admittance vs Drain Current



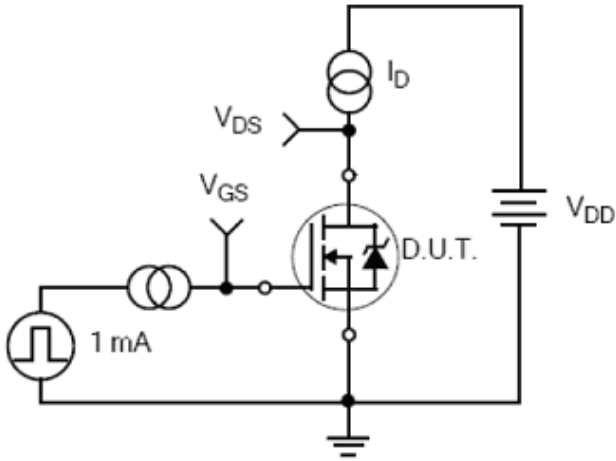
Single Pulse Power Rating, Junction to Case



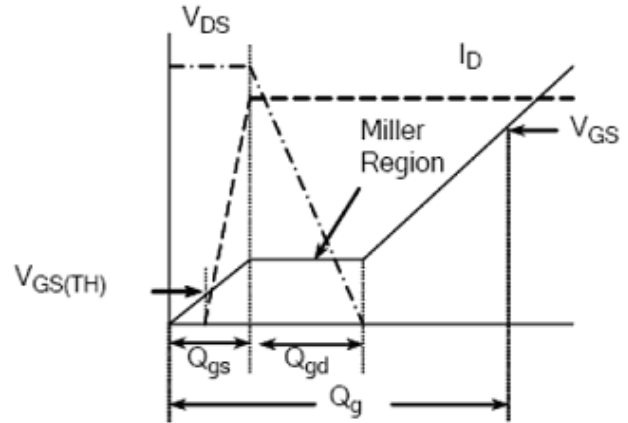
Transient Thermal Response Curves



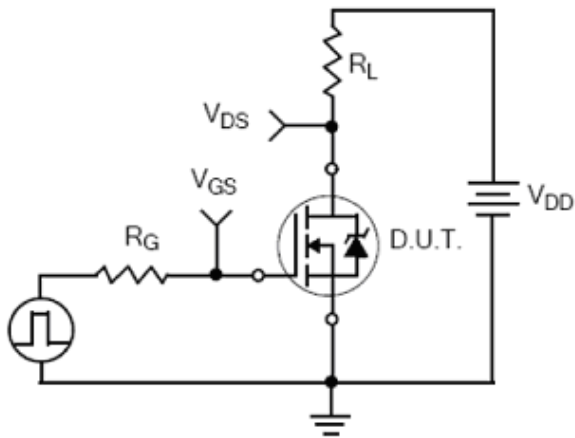
Test Circuit and Waveforms



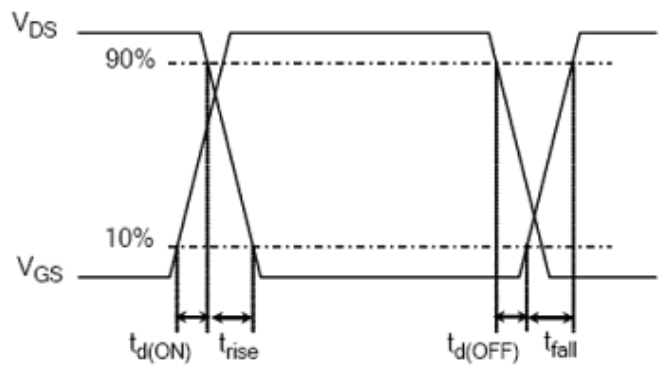
Gate Charge Test Circuit



Gate Charge Waveform

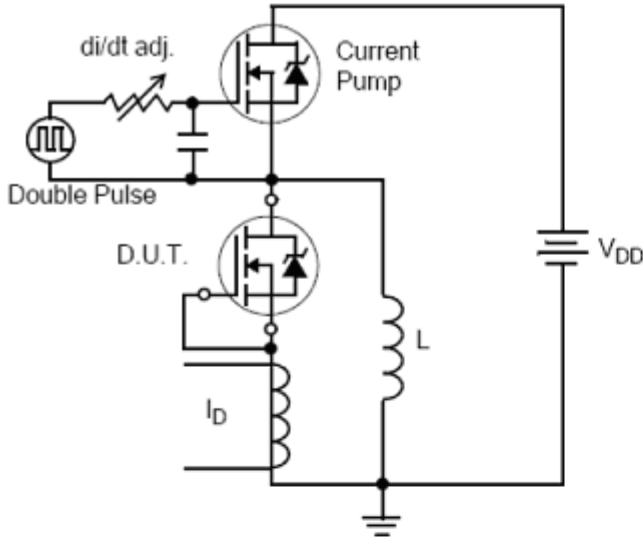


Resistive Switching Test Circuit

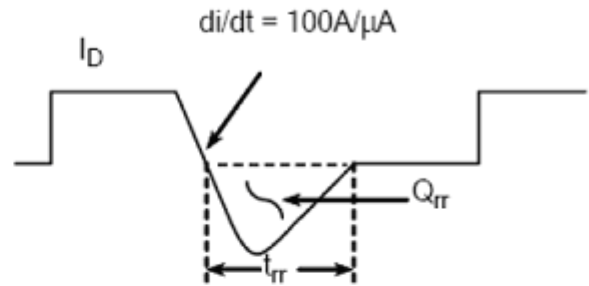


Resistive Switching Waveforms

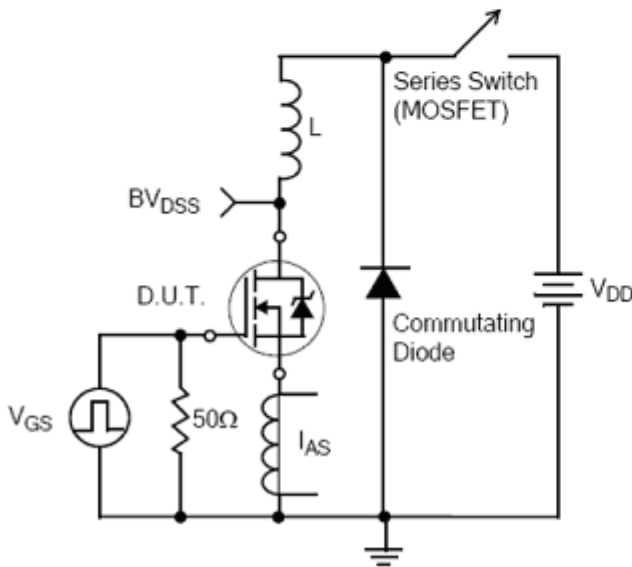
Test Circuit and Waveforms(Cont.)



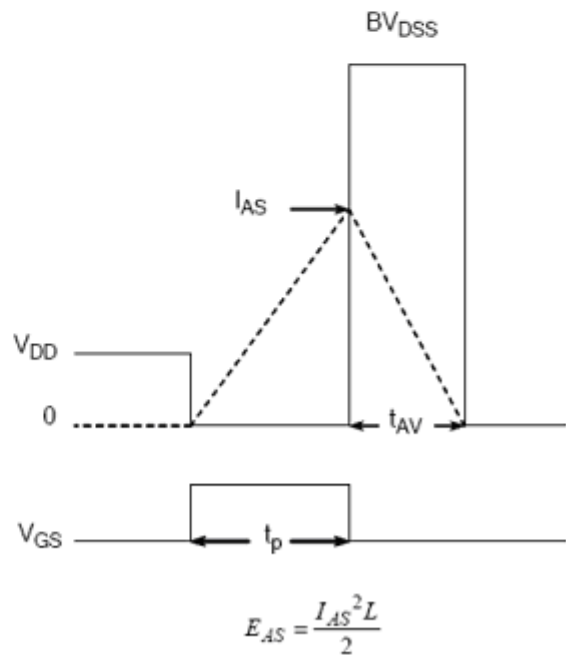
Diode Reverse Recovery Test Circuit



Diode Reverse Recovery Waveform



Unclamped Inductive Switching Test Circuit

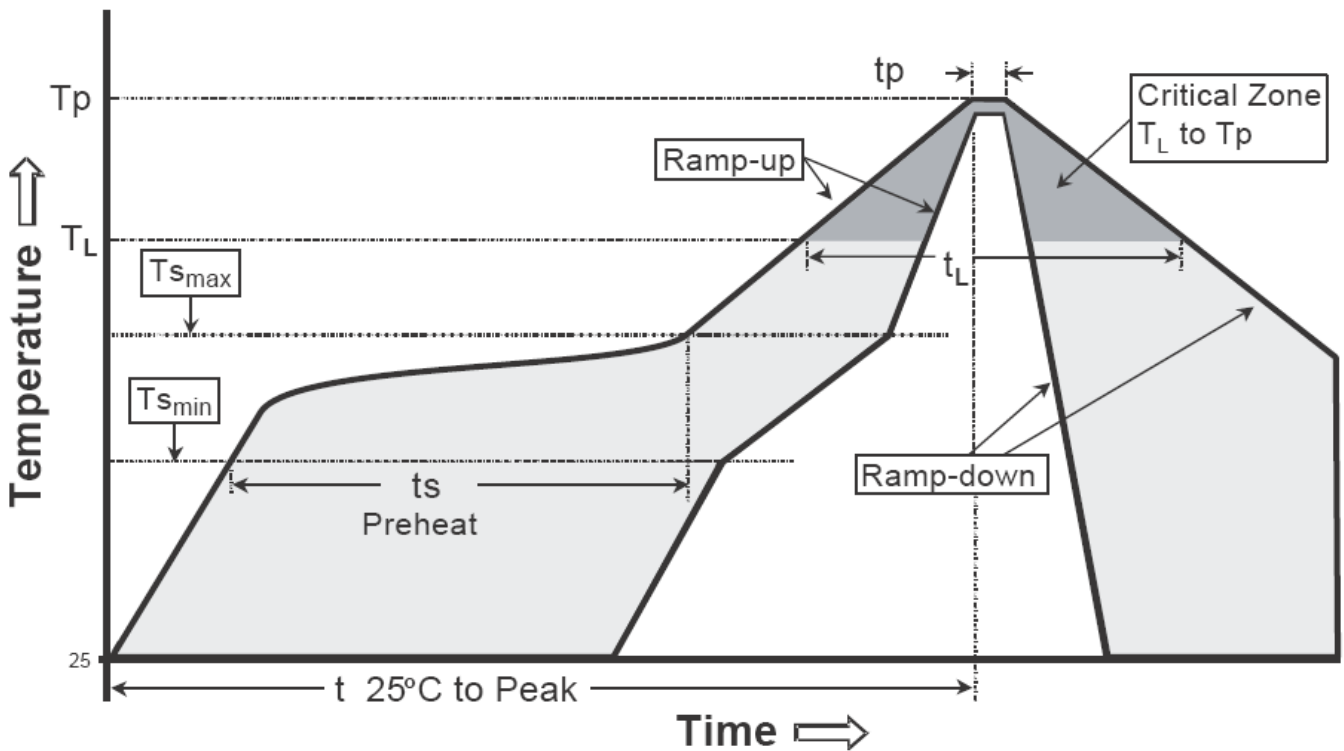


Unclamped Inductive Switching Waveforms

Recommended wave soldering condition

| | | |
|-----------------|------------------|-----------------|
| Product | Peak Temperature | Soldering Time |
| Pb-free devices | 260 +0/-5 °C | 5 +1/-1 seconds |

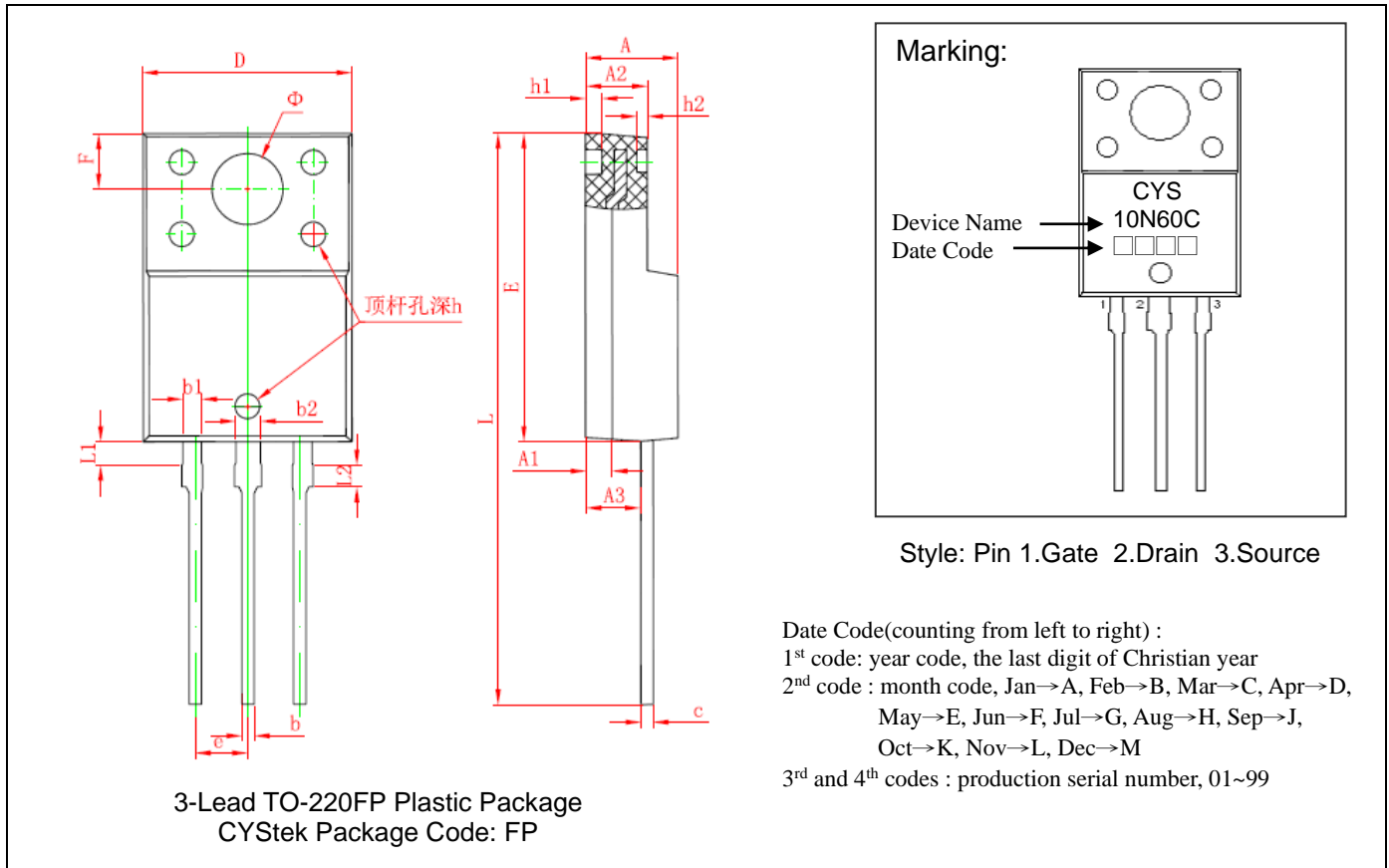
Recommended temperature profile for IR reflow



| Profile feature | Sn-Pb eutectic Assembly | Pb-free Assembly |
|---|-------------------------|------------------|
| Average ramp-up rate (T _{smax} to T _p) | 3°C/second max. | 3°C/second max. |
| Preheat | | |
| -Temperature Min(T _{s min}) | 100°C | 150°C |
| -Temperature Max(T _{s max}) | 150°C | 200°C |
| -Time(t _{s min} to t _{s max}) | 60-120 seconds | 60-180 seconds |
| Time maintained above: | | |
| -Temperature (T _L) | 183°C | 217°C |
| - Time (t _L) | 60-150 seconds | 60-150 seconds |
| Peak Temperature(T _P) | 240 +0/-5 °C | 260 +0/-5 °C |
| Time within 5°C of actual peak temperature(tp) | 10-30 seconds | 20-40 seconds |
| Ramp down rate | 6°C/second max. | 6°C/second max. |
| Time 25 °C to peak temperature | 6 minutes max. | 8 minutes max. |

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-220FP Dimension



3-Lead TO-220FP Plastic Package
 CYStek Package Code: FP

Marking:

Device Name → CYS 10N60C
 Date Code → □□□□

Style: Pin 1.Gate 2.Drain 3.Source

Date Code(counting from left to right) :
 1st code: year code, the last digit of Christian year
 2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D,
 May→E, Jun→F, Jul→G, Aug→H, Sep→J,
 Oct→K, Nov→L, Dec→M
 3rd and 4th codes : production serial number, 01~99

| DIM | Inches | | Millimeters | | DIM | Inches | | Millimeters | |
|-----|--------|-------|-------------|-------|-----|-----------|-------|-------------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Min. | Max. |
| A | 0.169 | 0.185 | 4.35 | 4.65 | e | 0.100 TYP | | 2.54 | TYP |
| A1 | 0.051 | REF | 1.30 | REF | F | 0.106 | REF | 2.70 | REF |
| A2 | 0.112 | 0.124 | 2.85 | 3.15 | Φ | 0.138 | REF | 3.50 | REF |
| A3 | 0.102 | 0.110 | 2.60 | 2.80 | h | 0.000 | 0.012 | 0.00 | 0.30 |
| b | 0.020 | 0.030 | 0.50 | 0.75 | h1 | 0.031 | REF | 0.80 | REF |
| b1 | 0.031 | 0.041 | 0.80 | 1.05 | h2 | 0.020 | REF | 0.50 | REF |
| b2 | 0.043 | 0.053 | 1.10 | 1.35 | L | 1.102 | 1.118 | 28.00 | 28.40 |
| c | 0.020 | 0.030 | 0.50 | 0.75 | L1 | 0.043 | 0.051 | 1.10 | 1.30 |
| D | 0.392 | 0.408 | 9.96 | 10.36 | L2 | 0.036 | 0.043 | 0.92 | 1.08 |
| E | 0.583 | 0.598 | 14.80 | 15.20 | | | | | |

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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